

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,317	BONALLE ET AL.	
Examiner	Art Unit	
Daniel I. Walsh	2876	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH (INCLUDING SEAF		()
	DATE	EXMR
EAST Search attached	1/23/2006	DW